Issue Classification

App	licatio	n/Con	trol No.
-----	---------	-------	----------

10654484

Examiner

Art Unit

KOBAYASHI ET AL.

Applicant(s)/Patent Under Reexamination

Lai, Daniel

2617

ORIGINAL CLASS SUBCLASS				INTERNATIONAL CLASSIFICATION												
				SUBCLASS	3	CLAIMED								AIMED		
455			466		·	Н	0	4	Q	7 / 20 (20	06.0)					
		DOSS DEE	EDENCE	<i>S)</i>	-	Н	0	4	В	7 / 00 (20	06.0)					
CROSS REFERENCE(S)					Н	0	4	Q	7 / 00 (2006.0	1.01)						
CLASS	LASS SUBCLASS (ONE SUBCLASS PER BLC				OCK)											
455	412.1	414.1									∤					
379	93.24					<u> </u>								<u> </u>		
709	206												<u> </u>		-	
		-											ļ			
	 				-											-
	 		-											ļ		
								-			\dashv					
		-			 								 			
													 	ļ		
	 			<u> </u>												,
	1							<u> </u>								
		<u> </u>			1								-			
·-··					 											
	1															
									 							
																·
-																
														<u> </u>		
	ļ <u>.</u>		ļ								_		ļ	ļ		
		<u> </u>	ļ						<u> </u>					<u> </u>		
	 _													ļ		
			 		 				_					ļ		•
	<u></u>	<u> </u>	1,	<u></u>		<u></u>			<u> </u>				<u> </u>	<u> </u>		
Lai, Daniel 1/3/2008		=	Greger							Total Claims Allowed:						
(Assistant Examiner) (Date)			DUC M. NGUYEN SUPERVISORY PATENT EXAMINER							8						
J. Johnson 1-9-08			TECHNOLOGY CENTER 2600							O.G. Print Claim(s)				O.G. Print Figure		
(Legal Instruments (Date) Examiner)				(Primary	(Primary Examiner) (Date)						1 1					